

N-Channel Enhancement Mode Power MOSFET

Description

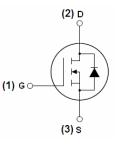
The HM100N20T uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

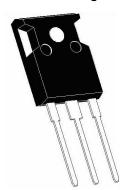
- $V_{DS} = 200V, I_{D} = 100A$ $R_{DS(ON)} < 18m\Omega @ V_{GS} = 10V$
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



Schematic diagram



TO-247 top view

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM100N20T	HM100N20T	TO-247	-		

Absolute Maximum Ratings (T_C=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	200	V	
Gate-Source Voltage	V _G s	±20	V	
Drain Current-Continuous	I _D	100	А	
Drain Current-Continuous(T _C =100 °C)	I _D (100℃)	70.7	Α	
Pulsed Drain Current	I _{DM}	400	А	
Maximum Power Dissipation	P _D	400	W	
Derating factor		2.67	W/℃	
Single pulse avalanche energy (Note 5)	Eas	1369	mJ	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 175	$^{\circ}$	

Thermal Characteristic

Thermal Resistance, Junction-to-Case ^(Note 2)	$R_{ heta JC}$	0.38	°C/W



Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	200	220	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =200V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2	3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =50A	-	13.5	18	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =50A	50	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	\/ -50\/\/ -0\/	-	9382	-	PF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V, F=1.0MHz	-	529	-	PF
Reverse Transfer Capacitance	C _{rss}	F=1.UIVIDZ	-	206	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	35	-	nS
Turn-on Rise Time	t _r	V_{DD} =100V, R_L =15 Ω	-	30	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10V, R_{G} =2.5 Ω	-	55	-	nS
Turn-Off Fall Time	t _f		-	25	-	nS
Total Gate Charge	Qg	\/ -400\/ L -50A	-	150.9		nC
Gate-Source Charge	Q _{gs}	V_{DS} =100V, I_{D} =50A, V_{GS} =10V	-	36.8		nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V	-	52.5		nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V_{SD}	V _{GS} =0V,I _S =50A	-		1.2	V
Diode Forward Current (Note 2)	Is		-	-	100	Α
Reverse Recovery Time	t _{rr}	TJ = 25°C, IF = 50A	-	52		nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs ^(Note3)	-	80		nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				
		•				

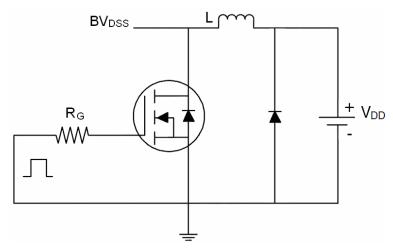
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- 5. E_{AS} condition: V_{DD} =50V, V_{G} =10V,L=0.5mH,Rg=25 Ω

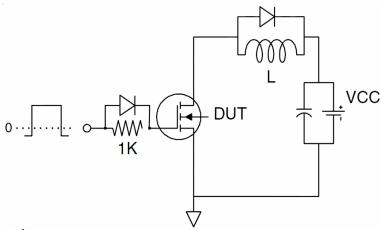


Test Circuit

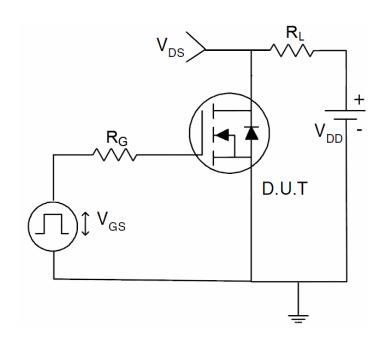
1) E_{AS} test Circuits



2) Gate charge test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves)

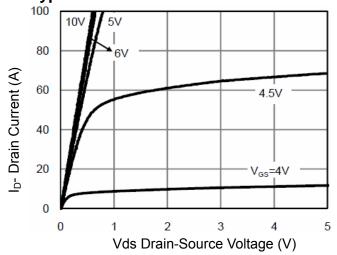


Figure 1 Output Characteristics

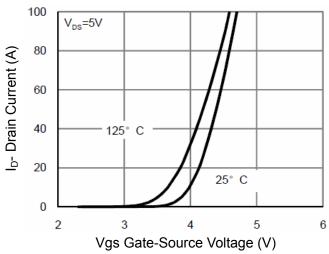


Figure 2 Transfer Characteristics

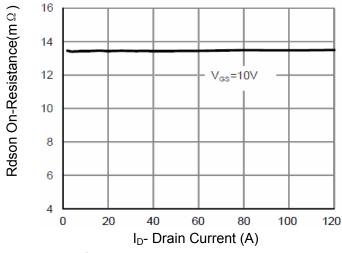


Figure 3 Rdson- Drain Current

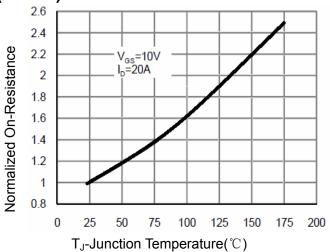


Figure 4 Rdson-Junction Temperature

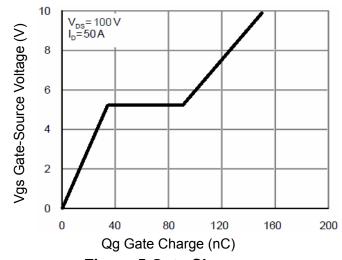


Figure 5 Gate Charge

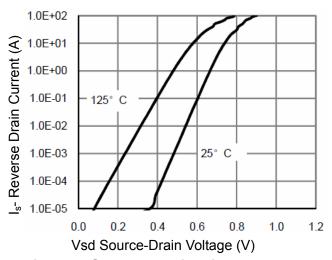
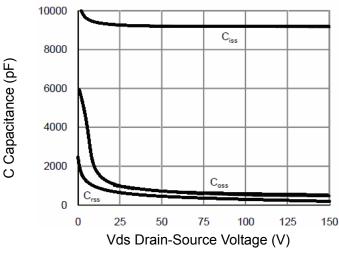


Figure 6 Source- Drain Diode Forward





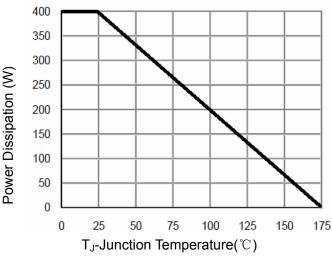
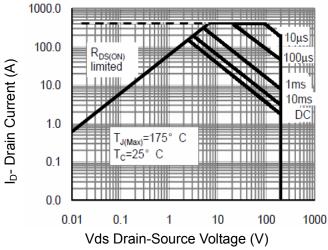


Figure 7 Capacitance vs Vds

Figure 9 Power De-rating



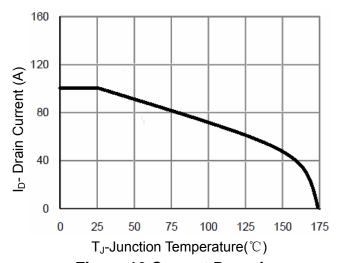


Figure 8 Safe Operation Area

Figure 10 Current De-rating

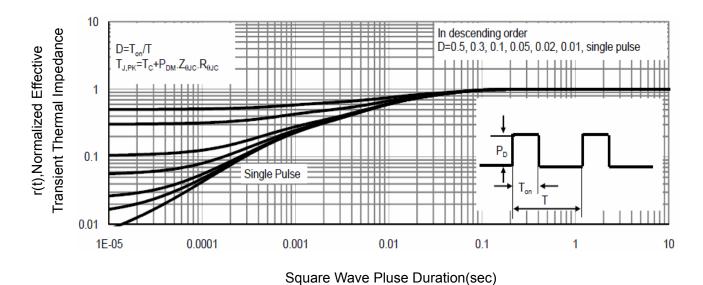
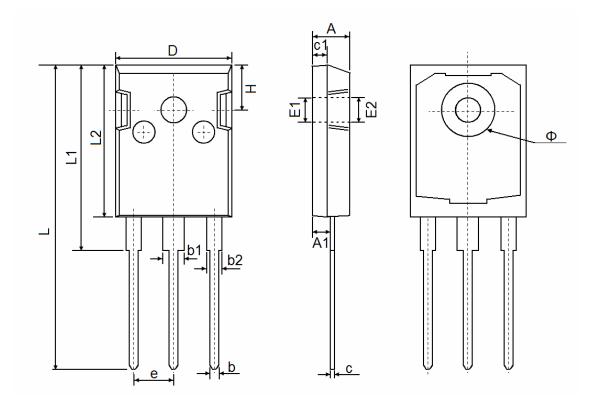


Figure 11 Normalized Maximum Transient Thermal Impedance



TO-247 Package Information



Symbol	Dimensions	In Millimeters	Dimensions In Inches			
Symbol	Min.	Max.	Min.	Max.		
Α	4.850	5.150	0.191	0.200		
A1	2.200	2.600	0.087	0.102		
b	1.000	1.400	0.039	0.055		
b1	2.800	3.200	0.110	0.126		
b2	1.800	2.200	0.071	0.087		
С	0.500	0.700	0.020	0.028		
c1	1.900	2.100	0.075	0.083		
D	15.450	15.750	0.608	0.620		
E1	3.500	REF	0.138 REF			
E2	3.600	0.142 REF		3.600 REF 0.142 REF		REF
L	40.900	41.300	1.610	1.626		
L1	24.800	25.100	0.976	0.988		
L2	20.300	20.600	0.799	0.811		
Ф	7.100	7.300	0.280	0.287		
е	5.450	5.450 TYP 0.215 TYP		TYP		
Н	5.980	5.980 REF 0.235 REF				





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